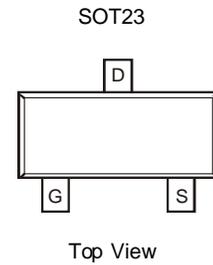


**N-Channel Enhancement-Mode MOSFET**
**Description and Applications**

This new generation MOSFET has been designed to minimize the on-state resistance ( $R_{DS(on)}$ ) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- Power management functions
- DC-DC Converters
- Backlighting


**■ MAXIMUM RATINGS**

Characteristic	Symbol	Max	Unit
Drain-Source Voltage	$BV_{DSS}$	50	V
Gate- Source Voltage	$V_{GS}$	$\pm 20$	V
Drain Current continuous	$I_{DR}$	173	mA
Drain Current-pulsed	$I_{DRM}$	700	mA

**■ THERMAL CHARACTERISTICS**

Characteristic	Symbol	Max	Unit
Total Device Dissipation $T_A=25^\circ\text{C}$ Derate above $25^\circ\text{C}$	$P_D$	830 1.8	mW mW/ $^\circ\text{C}$
Thermal Resistance Junction to Ambient	$R_{\theta JA}$	350	$^\circ\text{C}/\text{W}$
Junction and Storage Temperature	$T_J, T_{stg}$	150 $^\circ\text{C}$ , -55to+150 $^\circ\text{C}$	

**N-Channel Enhancement-Mode MOSFET**
**■ ELECTRICAL CHARACTERISTICS**

 (T<sub>A</sub>=25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
Drain-Source Breakdown Voltage (I <sub>D</sub> =10uA, V <sub>GS</sub> =0V)	BV <sub>DSS</sub>	50	—	—	V
Gate Threshold Voltage (I <sub>D</sub> =1mA, V <sub>GS</sub> =V <sub>DS</sub> )	V <sub>GS(th)</sub>	0.4	—	1.8	V
Drain-Source On Voltage (I <sub>D</sub> =50mA, V <sub>GS</sub> =5V) (I <sub>D</sub> =500mA, V <sub>GS</sub> =10V)	V <sub>DS(ON)</sub>	—	—	0.375 3.75	V
Diode Forward Voltage Drop (I <sub>SD</sub> =180mA, V <sub>GS</sub> =0V)	V <sub>SD</sub>	—	—	1.5	V
Zero Gate Voltage Drain Current (V <sub>GS</sub> =0V, V <sub>DS</sub> =40V) (V <sub>GS</sub> =0V, V <sub>DS</sub> =40V, T <sub>A</sub> =150°C)	I <sub>DSS</sub>	—	—	1 10	uA
Gate Body Leakage (V <sub>GS</sub> =±20V, V <sub>DS</sub> =0V)	I <sub>GSS</sub>	—	—	±100	nA
Static Drain-Source On-State Resistance (I <sub>D</sub> =100mA, V <sub>GS</sub> =10V) (I <sub>D</sub> =100mA, V <sub>GS</sub> =5V) (I <sub>D</sub> =10mA, V <sub>GS</sub> =2.5V)	R <sub>DS(ON)</sub>	—	—	15 20 30	Ω
Input Capacitance (V <sub>GS</sub> =0V, V <sub>DS</sub> =10V, f=1MHz)	C <sub>ISS</sub>	—	—	25	pF
Common Source Output Capacitance (V <sub>GS</sub> =0V, V <sub>DS</sub> =10V, f=1MHz)	C <sub>OSS</sub>	—	—	15	pF
Turn-ON Time (V <sub>DS</sub> =20V, V <sub>GS</sub> =10V, R <sub>GEN</sub> =50Ω)	t <sub>(on)</sub>	—	—	8	ns
Turn-OFF Time (V <sub>DS</sub> =20V, V <sub>GS</sub> =10V, R <sub>GEN</sub> =50Ω)	t <sub>(off)</sub>	—	—	15	ns
Reverse Recovery Time (I <sub>SD</sub> =180mA, V <sub>GS</sub> =0V)	t <sub>rr</sub>	—	30	—	ns

- FR-5=1.0×0.75×0.062in.
- Alumina=0.4×0.3×0.024in.99.5%alumina.
- Pulse Width≤300 μ s; Duty Cycle≤2.0%.

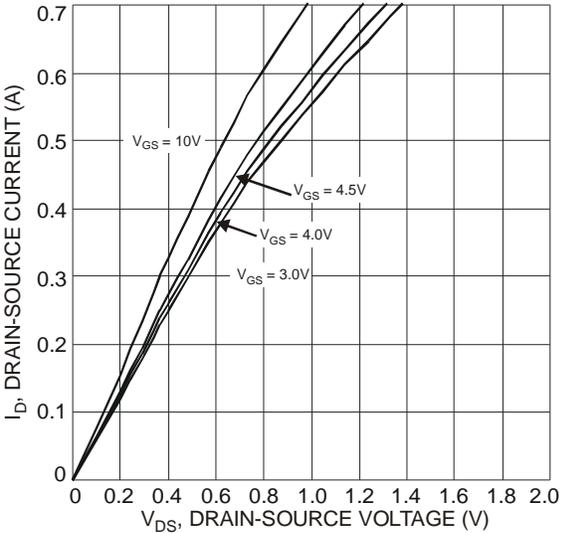


Fig. 1 Drain-Source Current vs. Drain-Source Voltage

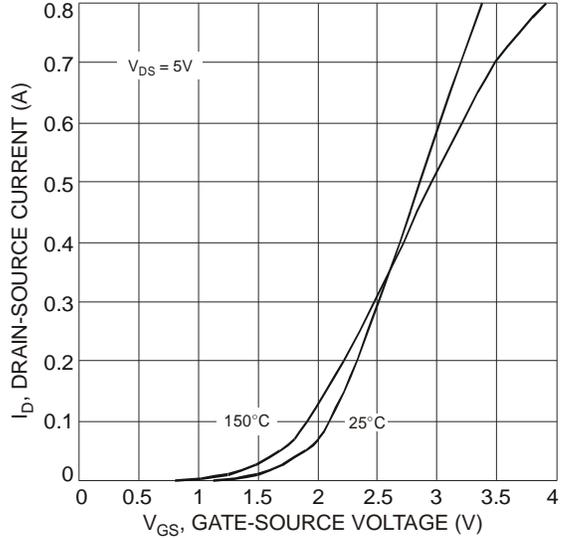


Fig. 2 Transfer Characteristics

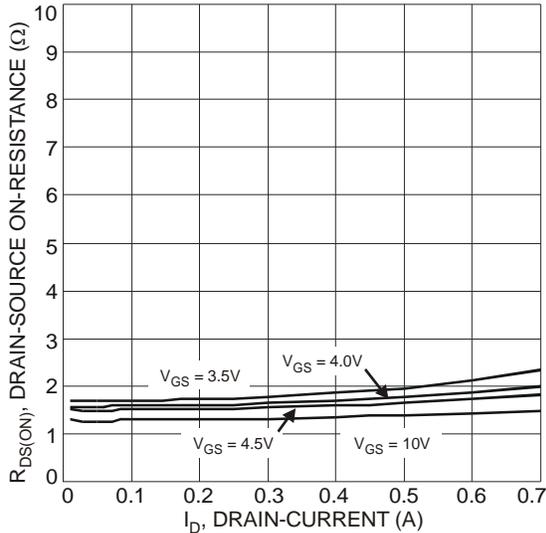


Fig. 3 Drain-Source On-Resistance vs. Drain-Current

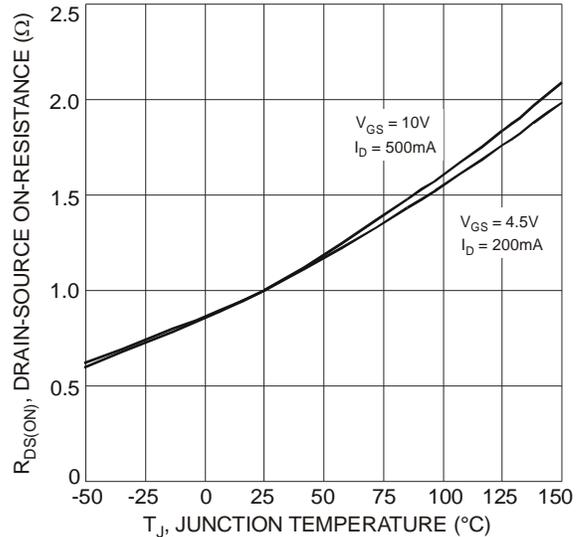


Fig. 4 Drain-Source On-Resistance vs. Junction Temperature

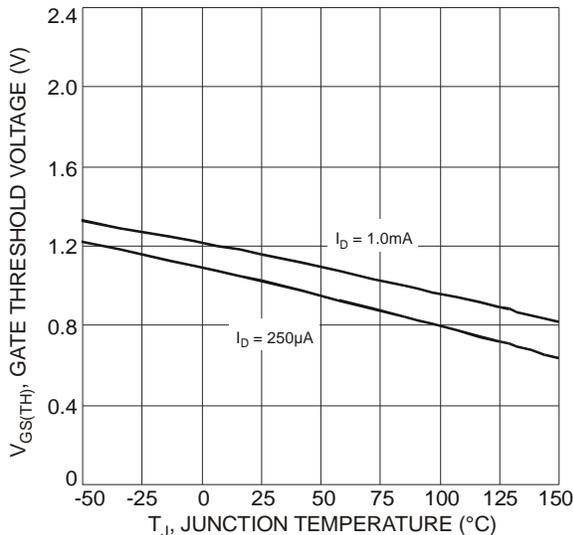


Fig. 5 Gate Threshold Voltage vs. Junction Temperature

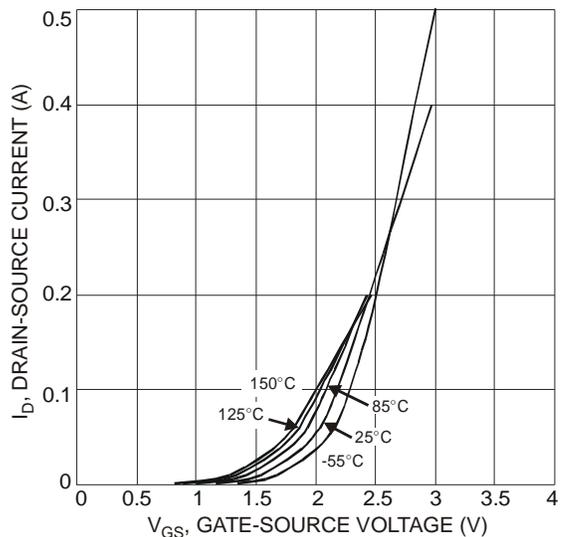


Fig. 6 Transfer Characteristics

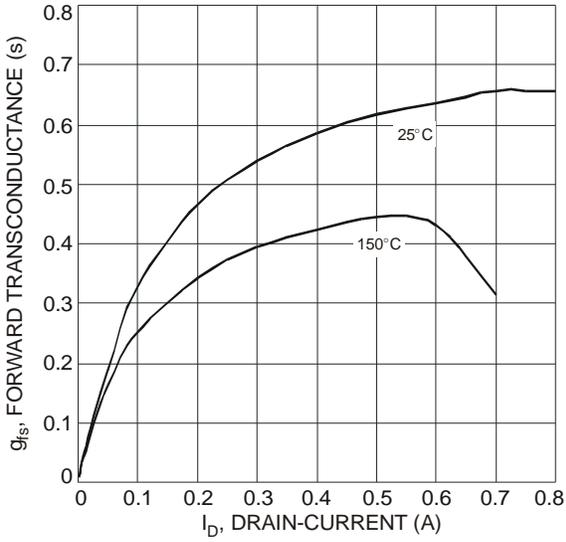


Fig. 7 Typical Transfer Characteristic

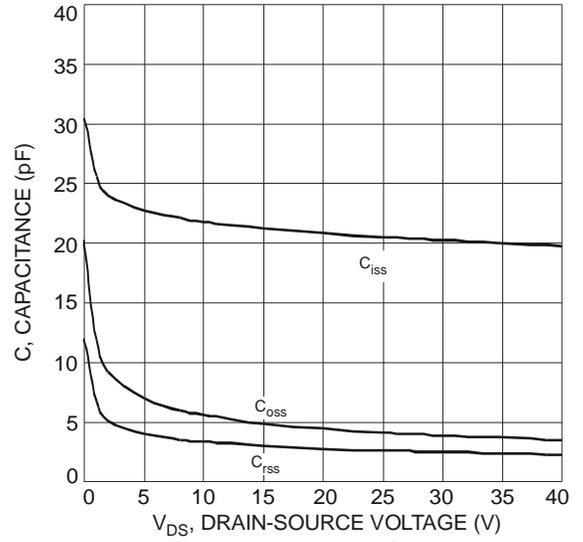


Fig. 8 Capacitance vs. Drain-Source Voltage

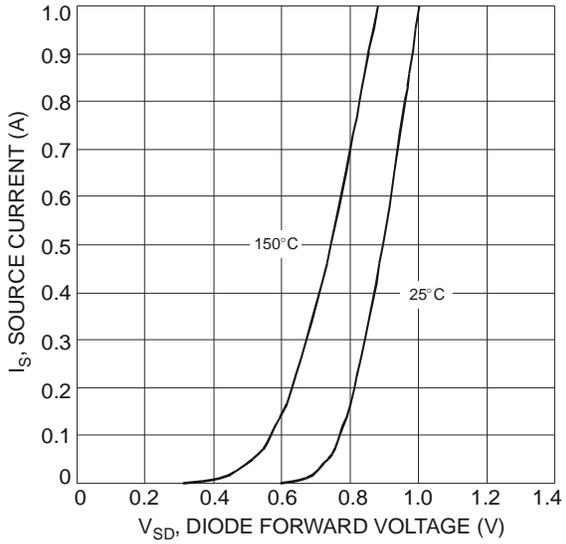
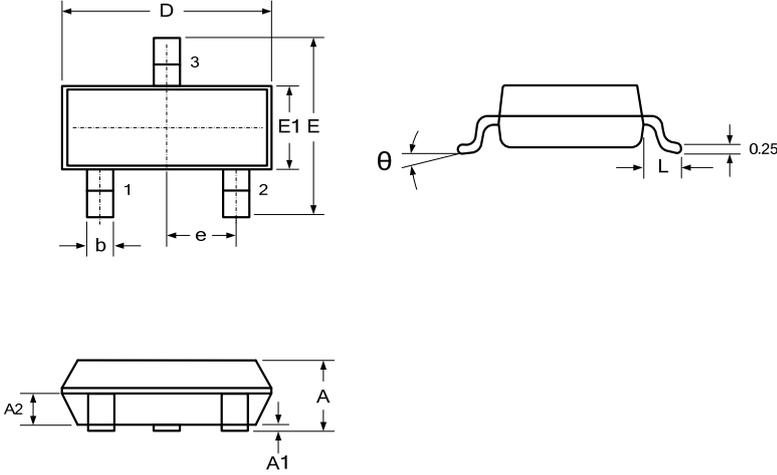


Fig. 9 Source Current vs. Diode Forward Voltage

**Outline Drawing – SOT-23**

<b>PACKAGE OUTLINE</b>		<b>SOT-23</b>			
					
<b>DIMENSIONS</b>					
SYMBOL	MILLIMETER		INCHES		
	MIN	MAX	MIN	MAX	
A	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
D	2.800	3.000	0.110	0.118	
b	0.300	0.500	0.012	0.020	
E	2.250	2.550	0.089	0.100	
E1	1.200	1.400	0.047	0.055	
e	0.950 BSC		0.037 BSC		
L	0.300	0.500	0.012	0.020	
$\theta$	0	$8^\circ$	0	$8^\circ$	

<b>DIMENSIONS</b>		
DIM	INCHES	MILLIMETERS
M	0.088	2.20
C	0.0058	0.15
Z	0.093	2.35
e	0.037 BSC	0.95 BSC
e1	0.074 BSC	1.9 BSC
b	0.0389	0.35

**Notes**

1. Dimensioning and tolerances per ANSI Y14.5M, 1985.
2. Controlling Dimension: Inches
3. Pin 3 is the cathode (Unidirectional Only).
4. Dimensions are exclusive of mold flash and metal burrs.